Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/669,679	IDE ET AL.	
Examiner	Art Unit	
EDMUND H. LEE	1732	

SEARCHED					
Class	Subclass	Date	Examiner		
UPDATED		5/26/2006	EHL		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
264	148,250	5/26/2006	EHL	
	173.16			
	320			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	5/26/2006	EHL		
UPDATED				
INVENTOR SEARCH				